

# STP12IE90F4

Emitter Switched Bipolar Transistor ESBT<sup>®</sup> 900 V - 12 A - 0.083 Ω

### **General features**

V <sub>CS(ON)</sub>	I <sub>C</sub>	R <sub>CS(ON)</sub>
1V	12A	0.083 Ω

- High voltage / high current Cascode configuration
- Low equivalent on resistance
- Very fast-switch up to 150 kHz
- Squared RBSOA up to 900V
- Very low  $C_{iss}$  driven by  $R_G = 47\Omega$
- Very low turn-off cross over time

### **Applications**

- Flyback SMPS for adapter
- Flyback / forward SMPS for desktop

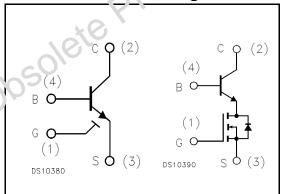
#### Description

The STP12IE90F4 is manufactured in Monolithic ESBT Technology, aimed to provide best performances in high frequency / high voltage applications.

It is designed for use in Gate Driver, based topologies.



### Internal schematic diagrams



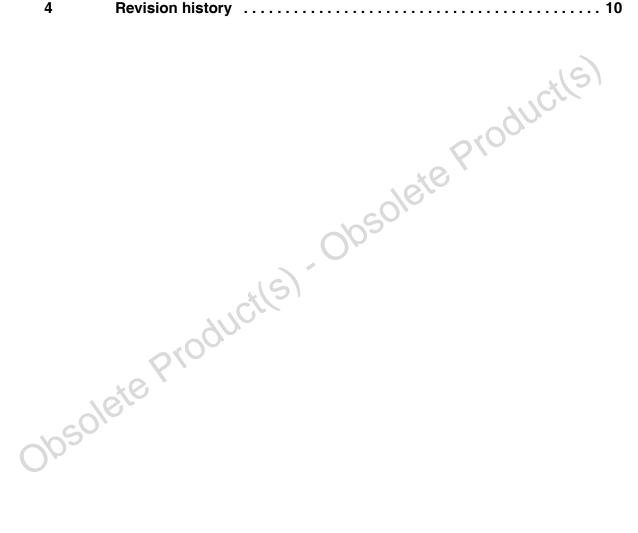
#### ೧೯ರ್ಷ codes

Part Number	Marking	Package	Packing
STP12IE90F4	P12IE90F4	TO220FP-4L	Tube

January 2007 Rev 2 1/11

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STP12IE90F4 **Electrical ratings** 

#### **Electrical ratings** 1

Table 1. Absolute maximum rating

Symbol	Parameter	Value	Unit
V <sub>CS(SS)</sub>	Collector-source voltage (V <sub>BS</sub> = V <sub>GS</sub> = 0 V)	900	V
V <sub>BS(OS)</sub>	Base-source voltage (I <sub>C</sub> = 0, V <sub>GS</sub> = 0 V)	30	٧
V <sub>SB(OS)</sub>	Source-base voltage (I <sub>C</sub> = 0, V <sub>GS</sub> = 0 V)	17	V
$V_{GS}$	Gate-source voltage	± 17	٧
I <sub>C</sub>	Collector current	12	Α
I <sub>CM</sub>	Collector peak current (t <sub>P</sub> < 5ms)	36	Α
I <sub>B</sub>	Base current	6	Α
I <sub>BM</sub>	Base peak current (t <sub>P</sub> < 5ms)	10	Α
P <sub>tot</sub>	Total dissipation at T <sub>c</sub> = 25°C	21	W
T <sub>stg</sub>	Storage temperature	-40 to 150	°C
T <sub>J</sub>	Max. operating junction temperature	150	°C

Table 2. Thermal data

	Table 2.	Max. operating junction temperature  Thermal data	ete	150	°C
	Symbol	Parameter		Value	Unit
	R <sub>thj-case</sub>	Thermal resistance junction-case	max	6	°C/W
Obsol	eteP	roduci(s)			

Electrical characteristics STP12IE90F4

# 2 Electrical characteristics

 $(T_{case} = 25^{\circ}C \text{ unless otherwise specified})$ 

Table 3. Electrical characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
I <sub>CS(SS)</sub>	Collector-source current (V <sub>BS</sub> = V <sub>GS</sub> = 0)	V <sub>CE</sub> = 900V			100	μΑ
I <sub>BS(OS)</sub>	Base-source current (I <sub>C</sub> = 0, V <sub>GS</sub> = 0)	V <sub>BS(OS)</sub> = 30V			10	μΑ
I <sub>SB(OS)</sub>	Source-base current (I <sub>C</sub> = 0, V <sub>GS</sub> = 0)	V <sub>SB(OS)</sub> = 17V			100	μΑ
IGS(OS)	Gate-source leakage	V <sub>GS</sub> = ± 17V			100	nA
V <sub>CS(ON)</sub>	Collector-source ON voltage	$V_{GS} = 10V$ $I_{C} = 12A$ $I_{B} = 2.4A$ $V_{GS} = 10V$ $I_{C} = 6A$ $I_{B} = 0.6A$		1 0.6	1/3	V V
h <sub>FE</sub>	DC current gain	V <sub>GS</sub> = 10V I <sub>C</sub> = 12A V <sub>CS</sub> = 1V V <sub>GS</sub> = 10V I <sub>C</sub> = 6A V <sub>CS</sub> = 1V	OÇ	5 15		
V <sub>BS(ON)</sub>	Base Source ON voltage	$V_{GS} = 10V$ $I_C = 12A$ $I_B = 2.4A$ $V_{GS} = 10V$ $I_C = 6A$ $I_B = 0.6A$		1.5 1.2		V V
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{BS} = V_{GS}$ $I_B = 250 \mu A$	2	3	4	V
C <sub>iss</sub>	Input capacitance	$V_{CS} = 25V$ $f = 1MHz$ $V_{GS} = 0V$		520		pF
Q <sub>GS(tot)</sub>	Gate-source Charge	V <sub>CS</sub> =25V V <sub>GS</sub> =10V V <sub>CB</sub> =0V I <sub>C</sub> =4A		21.3		nC
t <sub>s</sub>	INDUCTIVE LOAD Storage time Fall time	$V_{GS} = 10V \qquad \qquad R_G = 47\Omega$ $V_{Clamp} = 720V \qquad \qquad t_p = 4\mu s$ $I_C = 6A \qquad \qquad I_B = 1.2A$		610 10		ns ns
t <sub>s</sub>	INDUCTIVE LOAD Storage time Fall time	$V_{GS} = 10V$ $R_G = 47\Omega$ $V_{Clamp} = 720V$ $t_p = 4\mu s$ $I_C = 6A$ $I_B = 0.6A$		360 10		ns ns
V <sub>CSW</sub>	Maximum collector- source voltage switched without snubber	$R_G = 47\Omega$ $h_{FE} = 5$ $I_C = 12A$	900			٧

Table 3. Electrical characteristics

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>CS(dyn)</sub>	Collector-source dynamic voltage (500ns)	$\begin{aligned} &V_{CC} = &V_{Clamp} = &400 V \\ &V_{GS} = &10 V &I_{C} = &6 A \\ &I_{B} = &1.2 A &t_{peak} = &500 ns \\ &R_{G} = &47 \Omega &I_{Bpeak} = &6 A \left(I_{C}\right) \end{aligned}$		3.37		V
V <sub>CS(dyn)</sub>	Collector-source dynamic voltage (1µs)	$\begin{aligned} &V_{CC} = &V_{Clamp} = &400 V \\ &V_{GS} = &10 V &I_{C} = &6 A \\ &I_{B} = &1.2 A &t_{peak} = &500 ns \\ &R_{G} = &47 \Omega &I_{Bpeak} = &6 A \left(I_{C}\right) \end{aligned}$		1.75		٧

# 2.1 Electrical characteristics (curves)

Figure 1. DC current gain

Figure 2. Collector-source On voltage

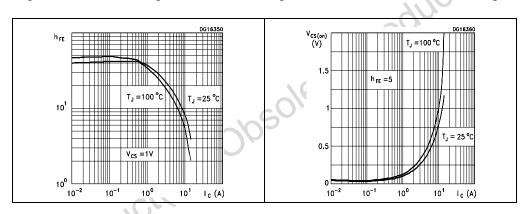
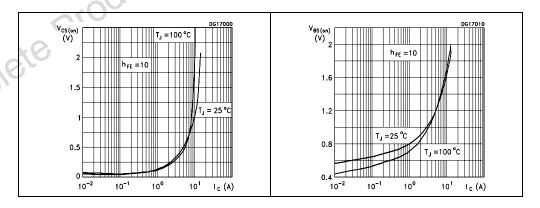


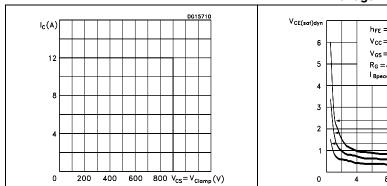
Figure 3. Collector-source On voltage Figure 4. Base-source On voltage



Electrical characteristics STP12IE90F4

Figure 5. Reverse biased SOA

Figure 6. Dynamic collector-emitter voltage



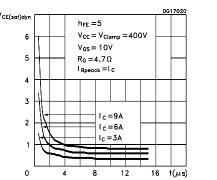
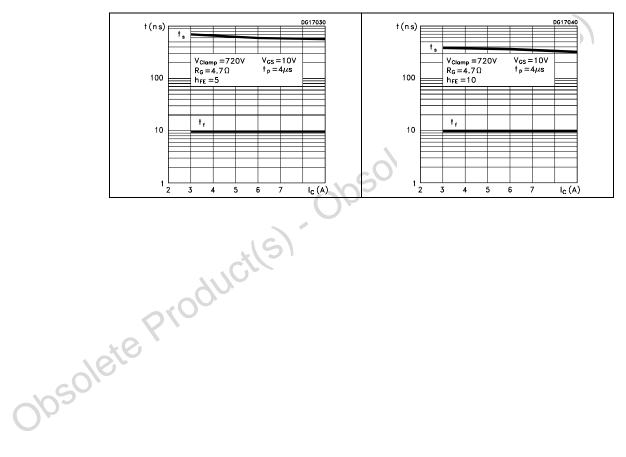


Figure 7. Inductive load switching time Figure 8. Inductive load switching time



### 2.2 Test circuits

Figure 9. Static V<sub>CS(ON)</sub> test circuits

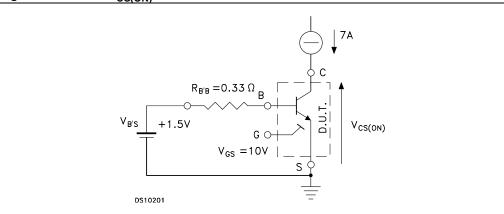
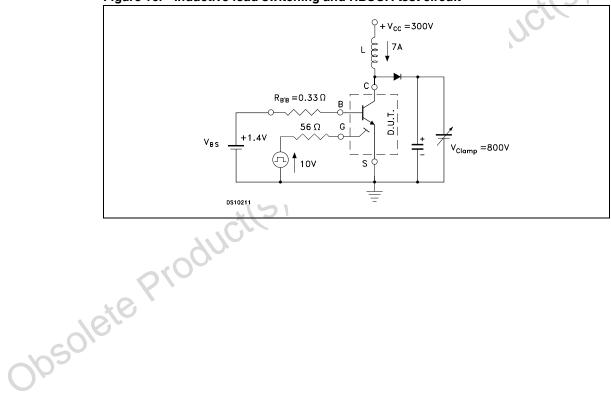


Figure 10. Inductive load switching and RBSOA test circuit



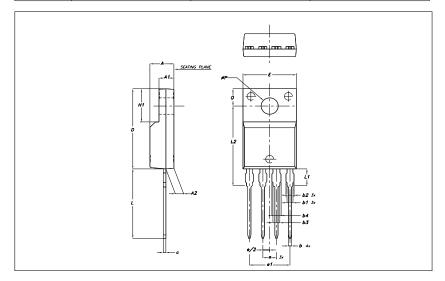
# 3 Package mechanical data

In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect. The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com



#### **TO220FP-4L MECHANICAL DATA**

DIM.	mm.			
DIW.	MIN.	TYP	MAX.	
Α	4.30		4.70	
A1	2.60		3	
A2	1.30	1.50	1.70	
b	0.50		0.70	
b1	1.05			
b2			1.30	
b3	1.25			
b4			1.50	
С	0.45	0.50	0.60	
D	15.50		15.90	
E	9.80		10.20	
е	2.29	2.54	2.79	
e1		7.62		
H1	6.30		6.70	
L		13.60		
L1		3.30		
L2	15.40		15.80	
Dia P	3		3.40	
Q	3.30		3.50	



Obsolete

Revision history STP12IE90F4

# 4 Revision history

Table 4. Revision history

Date	Revision	Changes
28-Jul-2006	1	Initial release.
16-Jan-2007	2	New graphics



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